TLV824 ... D OR PW PACKAGE

(TOP VIEW)

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- 2.7-V and 5-V Performance
- No Crossover Distortion
- Low Supply Current at V_{CC+} = 5 V: TLV821 ... 0.3 mA Typ TLV822 ... 0.5 mA Typ TLV824 ... 1 mA Typ
- Rail-to-Rail Output Swing
- Pin-to-Pin Compatible with LMV821, LMV822, and LMV824 Devices
- Package Options Include Plastic Small-Outline (D), Small-Outline Transistor (SOT-23 DBV, SC-70 DCK), and Thin Shrink Small-Outline (PW) Packages

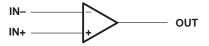
description

The TLV821, TLV822, and TLV824 devices are low-voltage (2.5 V to 5.5 V) low-power operational amplifiers, designed to be functionally and pin-to-pin compatible with the LMV821, LMV822, and LMV824 devices. Electrical characteristics are very similar to the LMV3xx operational amplifiers (low supply current, rail-to-rail outputs, input common-mode range, which includes ground). The TLV8xx devices have a significantly higher bandwidth (8 MHz typically) and a 2.5-V/µs slew rate. The TLV821 is a single, the TLV822 is a dual, and the TLV824 is a quad operational amplifier.

These devices are the most cost-effective solution for applications requiring low-voltage/low-power operation and space-saving considerations. The TLV821 is available in the ultra-small DCK package, which is approximately half the size of the DBV package. The DCK package saves space on PC boards and enables the design of small portable electronic devices (cordless and cellular phones, laptops, PDAs, PCMIAs). It also allows the designer to place the device closer to the signal source to reduce noise pickup and increase signal integrity.

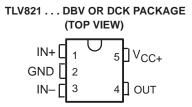
The TLV821I, TLV822I, and TLV824I devices are characterized for operation from -40°C to 85°C.

symbol (each amplifier)





1001	1	14 📙	4001
1IN-[2	13	4IN-
1IN+[3	12	4IN+
V _{CC+} [4	11	GND
2IN+[5	10	3IN+
2IN-[6	9]	3IN-
20UT	7	8]	3OUT
·			
TLV822			ACKAGE
	D OR		ACKAGE
10UT [EW) 8	V _{CC+}
10UT [1IN – [EW) 8 7	
10UT [8 7 6	V _{CC+} 20UT
10UT [1IN – [1IN + [1 2 3	EW) 8 7	V _{CC+} 20UT 2IN –



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AVAILABLE OPTIONS								
PACKAGE	PACKAGED DEVICES							
TYPE	SINGLE	DUAL	QUADRUPLE					
	TLV821IDCKR	—	—					
5-pin 501	TLV821IDBVR	—	—					
8-pin SOIC	—	TLV822ID	—					
8-pin TSSOP	—	TLV822IPWR	—					
14-pin SOIC	—	—	TLV824ID					
14-pin TSSOP	_	_	TLV824IPWR					
	PACKAGE TYPE 5-pin SOT 8-pin SOIC 8-pin TSSOP 14-pin SOIC	PACKAGE TYPEPAC SINGLE5-pin SOTTLV821IDCKR TLV821IDBVR8-pin SOIC—8-pin TSSOP—14-pin SOIC—	PACKAGE TYPE SINGLE DUAL 5-pin SOT TLV821IDCKR — 8-pin SOIC — TLV822IDBVR 8-pin TSSOP — TLV822IPWR 14-pin SOIC — —					

The D package is available taped and reeled. Add the suffix R to the device type (e.g., TLV824IDR). The DCK, DBV, and PW packages are only available left-end taped and reeled.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V _{CC} (see Note 1) 5.5 V
Differential input voltage, VID (see Note 2) ±5.5 V
Input voltage range, V _I (either input)
Duration of output short circuit (one amplifier) to ground at (or below) $T_A = 25^{\circ}C$,
$V_{CC} \le 5.5 \text{ V}$ (see Note 3) Unlimited
Operating virtual junction temperature 150°C
Package thermal impedance, θ_{JA} (see Notes 4 and 5): D (8-pin) package
D (14-pin) package
DBV package
DCK package
PW (8-pin) package
PW (14-pin) package
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D or PW package
Storage temperature range, T _{stg}
† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and
functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not
implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTES: 1. All voltage values (except differential voltages and V _{CC} specified for the measurement of I _{OS}) are with respect to the network GND.

les (except differential voltages and specified for the measurement of IOS) are with resp

- 2. Differential voltages are at IN+ with respect to IN-.
- 3. Short circuits from outputs to V_{CC} can cause excessive heating and eventual destruction.
- 4. Maximum power dissipation is a function of $T_J(max)$, θ_{JA} , and T_A . The maximum allowable power dissipation at any allowable ambient temperature is $P_D = (T_J(max) - T_A)/\theta_{JA}$. Selecting the maximum of 150°C can affect reliability.
- 5. The package thermal impedance is calculated in accordance with JESD 51.



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recommended operating conditions

		MIN	MAX	UNIT
VCC	Supply voltage (single-supply operation)	2.5	5.5	V
ТА	Operating free-air temperature	-40	85	°C

electrical characteristics at specified free-air temperature, V_{CC+} = 2.7 V, GND= 0 V, V_{CM} = 1 V, V_O = 1.35 V, and R_L > 1 M Ω (unless otherwise noted)

	PARAMETER	TEST CONDITI	ONS	TA	MIN	TYP	MAX	UNIT
\/	land affect veltage			25°C		1	3.5	
VIO	Input offset voltage			–40°C to 85°C			4	mV
$\alpha_{V_{IO}}$	Average temperature coefficient of input offset voltage			25°C		1		μV/°C
IIB	Input bias current			25°C		30	90	nA
чв				–40°C to 85°C			140	
IIO	Input offset current			25°C		0.5	30	nA
-10				–40°C to 85°C			50	
CMRR	Common-mode rejection ratio	V _{CM} = 0 to 1.7 V		25°C	60	73		dB
				–40°C to 85°C	58			
	Positive supply-voltage	$V_{CC+} = 1.7 V \text{ to } 4 V,$		25°C	60	75		dB
+kSVR	rejection ratio	GND = 1 V, $V_{CM} = 0, V_{O} = 0$		–40°C to 85°C	58			
L	Negative supply-voltage	$V_{CC+} = 1.7 V,$		25°C	60	75		
-ksvr	rejection ratio	GND = -1 V to -3.3 V, $V_{CM} = 0, V_{O} = 0$		–40°C to 85°C	58			dB
.,	Common-mode input voltage		0500	-0.2	-0.3		N	
VICR	range	CMRR ≥ 50 dB	25	25°C	1.9	2		V
	$R_{L} = 600 \Omega^{-1}$	$ \begin{array}{l} {\sf R}_{\sf L} = 600 \; \Omega \; \; \mbox{to} \; 1.35 \; \mbox{V}, \\ {\sf V}_{\sf O} = 1.35 \; \mbox{V} \; \mbox{to} \; 2.2 \; \mbox{V} \end{array} \mbox{Sourcing} $	Coursing	25°C	90	100		
			Sourcing	–40°C to 85°C	85			
		$R_{L} = 600 \Omega$ to 1.35 V,	Qiaking	25°C	85	90		
A	Large-signal	$V_{O} = 1.35 \text{ V to } 0.5 \text{ V}$	Sinking	–40°C to 85°C	80			dB
AVD	differential-voltage amplification	$R_{I} = 2 k\Omega$ to 1.35 V,	Coursing	25°C	95	100		uБ
		V _O = 1.35 V to 2.2 V	Sourcing	–40°C to 85°C	90			
		$R_{I} = 2 k\Omega$ to 1.35 V,	Cintring	25°C	90	95		
		$V_{O} = 1.35 \text{ V to } 0.5 \text{ V}$	Sinking	–40°C to 85°C	85			
		i i		25°C	2.5	2.58		
		V _{CC+} = 2.7 V,	High level	–40°C to 85°C	2.4			
		$R_{L} = 600 \Omega$ to 1.35 V		25°C		0.13	0.2	
			Low level	-40°C to 85°C			0.3	
	Output swing		LP at Laws	25°C	2.6	2.66		V
		$V_{CC+} = 2.7 V,$ High lev	High level	–40°C to 85°C	2.5			
		$R_L = 2 k\Omega$ to 1.35 V		25°C		0.08	0.12	
			Low level	–40°C to 85°C			0.2	



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electrical characteristics at specified free-air temperature, V_{CC+} = 2.7 V, GND = 0 V, V_{CM} = 1 V, V_O = 1.35 V, and R_L > 1 M Ω (unless otherwise noted) (continued)

	PARAMETER	TEST CONDITIONS		TA	MIN	TYP	MAX	UNIT
1.0		VO = 0 V	Sourcing	25°C	12	16		
10	Output current	V _O = 2.7 V	Sinking	25°C	12	26		mA
		TLV8211	-	25°C		0.22	0.3	
		TLVOZII		-40°C to 85°C			0.5	
1	Cupply ourrent			25°C		0.45	0.6	
ICC	Supply current	TLV822I (both amplifiers)		-40°C to 85°C			0.8	mA
		TLV824I (all four amplifiers)		25°C		0.72	1	
				-40°C to 85°C			1.2	
SR	Slew rate	V _{CC+} = 5 V [†]		25°C		2		V/µs
GBM	Gain-bandwidth product			25°C		7		MHz
φm	Phase margin			25°C		61		deg
Gm	Gain margin			25°C		10		dB
	Amplifier-to-amplifier isolation	$V_{CC+} = 5 \text{ V}, \text{ R}_{L} = 100 \text{ k}\Omega$	to 2.5 V‡	25°C		135		dB
Vn	Equivalent input noise voltage	f = 1 kHz, V _{CM} = 1 V		25°C		28		nV/√Hz
In	Equivalent input noise voltage	f = 1 kHz		25°C		0.1		pA/√Hz
THD	Total harmonic distortion	f = 1 kHz, A _{VD} = −2, R _L = 10 kΩ, V _C) = 4.1 Vpp	25°C		0.01%		

[†] Connected as voltage follower with 3-V step input. Value specified is the slower of the positive and negative slew rates.

[‡] Refers to inputs only. Each amplifier is excited, in turn, with 1 kHz to produce $V_0 = 3 V_{PP}$.



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	PARAMETER	TEST CONDIT	IONS	TA	MIN	TYP	MAX	UNIT
M	hand affect wells as			25°C	25°C 1		3.5	mV
VIO	Input offset voltage			-40°C to 85°C			4	
$\alpha_{V_{IO}}$	Average temperature coefficient of input offset voltage			25°C		1		μV/°C
IIB	Input bias current			25°C		40	100	nA
ΊΒ	input bias current			–40°C to 85°C			150	
IIO	Input offset current			25°C		0.5	30	nA
U	input onset current			–40°C to 85°C			50	
CMRR	Common-mode rejection	$V_{CM} = 0$ to 4 V		25°C	62	75		dB
CIVILAT	ratio	VCM = 0.10 4 V		–40°C to 85°C	60			uD
	Positive supply-voltage	V _{CC+} = 1.7 V to 4 V,	25°C	60	75			
+kSVR	rejection ratio	GND = -1 V, $V_{CM} = 0, V_{O} = 0$		–40°C to 85°C	58			dB
	Negative supply-voltage	V _{CC+} = 1.7 V,		25°C	60	75		
-ksvr	rejection ratio	GND = -1 V to -3.3 V, $V_{CM} = 0, V_{O} = 0$		–40°C to 85°C	58			dB
	Common-mode input		25°C	-0.2	-0.3		v	
VICR	voltage range	CMRR ≥ 50 dB		4.2	4.3			
				25°C	95	105		
			Sourcing	-40°C to 85°C	90			dB
			Cipking	25°C	95	105		
Δ	Large-signal		Sinking	-40°C to 85°C	90			
AVD	differential-voltage amplification	$R_L = 2 k\Omega$ to 2.5 V,	Coursing	25°C	95	105		
		$V_{O} = 2.5 \text{ V to } 4.5 \text{ V}$	Sourcing	-40°C to 85°C	90			
		$R_L = 2 k\Omega$ to 2.5 V,	Cipling	25°C	95	105		1
		$V_{O} = 2.5 \text{ V to } 0.5 \text{ V}$	Sinking	-40°C to 85°C	90			
				25°C	4.75	4.84		
		V _{CC+} = 5 V,	High level	-40°C to 85°C	4.7			1
		$R_{L} = 600 \Omega$ to 2.5 V		25°C		0.17	0.25	1
			Low level	-40°C to 85°C			0.3	1
	Output swing		2 kΩ to 2.5 V	25°C	4.85	4.9		V
		V _{CC+} = 5 V,		-40°C to 85°C	4.8			1
		$R_L = 2 k\Omega$ to 2.5 V		25°C		0.1	0.15	1
			Low level	-40°C to 85°C			0.2	1
				25°C	20	45		
		V _O = 0 V	Sourcing	-40°C to 85°C	15			1.
IO	Output current			25°C	20	40		mA
		$V_{O} = 5 V$	Sinking	-40°C to 85°C	15			

electrical characteristics at specified free-air temperature, V_{CC+} = 5 V, GND= 0 V, V_{CM} = 2 V, V_O = 2.5 V, and R_L > 1 M Ω (unless otherwise noted)



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electrical characteristics at specified free-air temperature, V_{CC+} = 5 V, GND = 0 V, V_{CM} = 2 V, V_O = 2.5 V, and R_L > 1 M Ω (unless otherwise noted) (continued)

	PARAMETER	TEST CONDITIONS	TA	MIN	TYP	MAX	UNIT
		T1)/0041	25°C		0.3	0.4	
		TLV821I	-40°C to 85°C			0.6	
1	Supply ourropt	TLV822I (both amplifiers)	25°C		0.5	0.7	mA
ICC	Supply current	TEV8221 (both amplifiers)	-40°C to 85°C			0.9	mA
			25°C		1	1.3	
		TLV824I (all four amplifiers)	-40°C to 85°C			1.5	
SR	Slew rate	V _{CC+} = 5 V [†]	25°C	2	2.5		V/μs
GBM	Gain-bandwidth product		25°C		8		MHz
φm	Phase margin		25°C		67		deg
Gm	Gain margin		25°C		15		dB
	Amplifier-to-amplifier isolation	$V_{CC+} = 5 \text{ V}, \text{ R}_{L} = 100 \text{ k}\Omega \text{ to } 2.5 \text{ V}^{\ddagger}$	25°C		135		dB
Vn	Equivalent input noise voltage	f = 1 kHz, V _{CM} = 1 V	25°C		24		nV/√Hz
In	Equivalent input noise voltage	f = 1 kHz	25°C		0.25		pA/√Hz
THD	Total harmonic distortion	f = 1 kHz, A _{VD} = -2, R _L = 10 kΩ, V _O = 4.1 V _{PP}	25°C		0.01%		

[†] Connected as voltage follower with 3-V step input. Value specified is the slower of the positive and negative slew rates.

[‡] Refers to inputs only. Each amplifier is excited, in turn, with 1 kHz to produce $V_0 = 3 V_{PP}$.

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